

**FLUKE**®

# 5320A

## Multifunction Electrical Tester Calibrator



**Extended Specifications**

## General Specifications

<b>Warm-Up Time</b>	30 minutes
<b>Specifications Confidence Level</b>	99 %
<b>Specifications Interval</b>	1 year
<b>Temperature Performance</b>	
Operating Temperature	18 to 28 °C
Calibration Temperature (tcal)	23 °C
Temperature Coefficient	Temperature coefficient for temperature outside of Tcal ±5 °C between +5 °C to +40 °C is 0.1 x /°C
Storage Temperature	-20 to +70 °C
<b>Relative Humidity (operating)</b>	<70 % to 28 °C
<b>Altitude</b>	
Operating	3,050 m (10,000 ft.)
Storage	12,200 m (40,000 ft.)
<b>Dimensions</b>	450 mm X 480 mm X 170 mm (17.7 in. X 18.9 in. X 6.7 in.)
<b>Weight</b>	18 kg (39.7 lbs.)
<b>Power Line</b>	115/230 V ac (50/60 Hz) ±10 %
<b>Power Consumption</b>	150 VA Maximum
<b>Safety Class</b>	Class I, Bonded Enclosure
<b>Electrostatic Discharge</b>	This instrument meets class I for ESD requirements per EN 61326 (Criteria A)
<b>△ Fuse Protection</b>	
AC mains input	2 A, 250 V for 230 V, Time delay (T2L250 V – 5 x 20 mm) 4 A, 250 V for 115 V, Time delay (T4L250 V – 5 x 20 mm)
RCD input	3.15 A, 250 V, Fast (F3.15L250V – 5 x 20 mm)
Meter amps (A) input	20 A, 500 V, Time delay (T20L500V – 6.3 x 32 mm)
Loop/Line impedance input	4 A, 250 V, Time delay (T4L250V – 6.3 x 32 mm)
Leakage current input	100 mA, 150V, Fast (F100mL150V – 5 x 20 mm)

## Electrical Specifications

### Low Resistance Source

<b>Total Range</b>	100 mΩ to 10 kΩ
<b>Resolution</b>	3½ digits (continuously variable)

#### Uncertainty and Maximum Ratings

Range	Resolution	Maximum AC or DC Current <sup>[1]</sup>	2-Wire Uncertainty <sup>[2]</sup> (tcal ±5 °C)	4-Wire Uncertainty (tcal ±5 °C)
100 mΩ to 4.99 Ω	0.1 mΩ	400 mA	0.3 % + 25 mΩ	0.3 % + 10 mΩ
5 to 29.9 Ω	0.01 Ω	250 mA	0.2 % + 25 mΩ	0.2 % + 10 mΩ
30 to 199.9 Ω	0.1 Ω	100 mA	0.2 % + 25 mΩ	0.2 % + 10 mΩ
200 to 499 Ω	1 Ω	45 mA	0.2 %	0.2 %
500 Ω to 1,999 kΩ	1 Ω	25 mA	0.2 %	0.2 %
2 to 4.99 kΩ	10 Ω	10 mA	0.2 %	0.2 %
5 to 10 kΩ	10 Ω	5 mA	0.2 %	0.2 %

Notes:

[1] Test current can exceed 120 % of maximum current for up to 3 seconds. Terminals automatically disconnect if test current exceeds 120 % of specified maximum current.

[2] Uncertainty is valid to 200 mW. For higher power rating, add 0.1 % per each 300 mW above 200 mW.

### Test Current Measurement

<b>Range</b>	0 to 400 mA ac + dc rms
<b>Resolution</b>	1 mA
<b>Uncertainty</b>	$\left( \left( \frac{20}{\sqrt{R}} \right) + 0.1 \right) \text{mA}$ R = set resistance between 0.5 Ω to 10 kΩ.

### Short Mode

<b>Nominal resistance</b>	<50 mΩ
<b>Maximum current</b>	400 mA ac + dc rms

### Open Mode

<b>Nominal resistance</b>	30 MΩ ±20 %
<b>Maximum input voltage allowed</b>	50 V ac + dc rms
<b>Test voltage reading</b>	0 to 50 V ac + dc rms
<b>Resolution</b>	1 V
<b>Uncertainty</b>	5 % + 2 V

## High Resistance Source

**Range**.....10 kΩ to 10 GΩ plus 100 GΩ single value selection.  
**Resolution**.....4½ Digit (continuously variable for 10 kΩ to 10 GΩ range)

### Uncertainty and Maximum Ratings

Range	Resolution	Maximum Voltage (ac+dc) Peak	Uncertainty <sup>[1]</sup> (tcal ±5 °C)
10.000 to 39.99 kΩ	1 Ω	55 V	0.2 %
40.00 to 99.99 kΩ	10 Ω	300 V	0.2 %
100.00 to 199.99 kΩ	10 Ω	800 V	0.2 %
200.0 to 999.9 kΩ	100 Ω	1100 V	0.2 %
1.0000 to 9.999 MΩ	100 Ω	1150 V	0.3 %
10.000 to 999.9 MΩ	1 kΩ	1575 V <sup>[2]</sup>	0.5 %
1.0000 to 10.000 GΩ	100 kΩ	1575 V <sup>[2]</sup>	1.0 %
100 GΩ	NA	1575 V <sup>[2]</sup>	3.0 % <sup>[3]</sup>

Notes:

[1] Uncertainty is valid to 500 volts. For test voltages above 500 V, add 0.1% for each 200 V above 500 V.

[2] Maximum test voltage with the supplied banana leads is 1000 Vrms. For higher voltages, use leads rated at 1575 V or above.

[3] Calibration value uncertainty is specified in the table. Nominal value is ± 15 %.

### Test Voltage Measurement

**Range**.....0 to 2000 V dc peak  
**Resolution**.....1 V  
**Uncertainty**.....1 % + 5 V for R above 1 MΩ  
                           1 % + 2 V for R below 1 MΩ  
**Settling Time** .....2 seconds for input deviations of <5 %

### Test Current Measurement

**Range**.....0 to 9.9 mA dc  
**Uncertainty**.....1.5 % + 5V/R A (where R is the selected resistance value)  
**Settling time**.....2 seconds (for voltage reading deviations < 5 %)

### Short Mode

**Nominal resistance** .....<100 Ω  
**Maximum input current allowed** .....50 mA ac + dc rms  
**Test current range** .....0 to 50 mA ac + dc rms  
**Resolution**.....0.1 mA  
**Uncertainty**.....2 % + 0.5 mA

### Resistance Multiplier Adapter (x1000 multiplier)

**Resistance range** .....350 MΩ to 10 TΩ

### Uncertainty and Maximum Ratings

Range	Resolution	Maximum Voltage (ac+dc) Peak	Uncertainty (tcal ±5 °C)
350.0 MΩ to 99.99 GΩ	100 kΩ	10000 V	1.0 % + R <sup>[1]</sup>
100.00 GΩ to 999.9 GΩ	10 MΩ	10000 V	2.0 % + R <sup>[1]</sup>
1.0000 TΩ to 10.000 TΩ	100 MΩ	10000 V	3.0 % + R <sup>[1]</sup>

Notes:

[1] R is the uncertainty of resistor to be multiplied by 1000.

## Ground Bond Resistance Source

**Range** ..... 25 mΩ to 1.8 kΩ  
**Resolution** ..... 16 discrete values  
**Minimum test voltage/current** ..... 10 V / 10 mA

### Uncertainty and Maximum Ratings

Nominal Value	Deviation from Nominal Value	Absolute Uncertainty of Characterized Value (tcal ± 5 °C)	Maximum Continuous Test Current ACrms or DC <sup>[1]</sup>	Maximum Short-term Test Current AC rms or DC <sup>[2]</sup>	Test Current Uncertainty
25 mΩ	±50 %	± 5 mΩ	30 A	40 A	1.5 % + 0.7 A
50 mΩ	±50 %	± 5 mΩ	28 A	40 A	1.5 % + 0.5 A
100 mΩ	±30 %	± 5 mΩ	25 A	40 A	1.5 % + 0.35 A
330 mΩ	±20 %	± 7 mΩ	14 A	40 A	1.5 % + 0.3 A
500 mΩ	±10%	± 8 mΩ	10 A	40 A	1.5 % + 0.2 A
1 Ω	±10 %	± 10 mΩ	8 A	40 A	1.5 % + 150 mA
1.8 Ω	±10%	± 18 mΩ	6 A	30 A	1.5 % + 100 mA
5 Ω	±10 %	± 30 mΩ	3.2 A	21 A	1.5 % + 70 mA
10 Ω	±10 %	± 60 mΩ	2.0 A	15 A	1.5 % + 50 mA
18 Ω	±10 %	± 100 mΩ	1.5 A	10 A	1.5 % + 30 mA
50 Ω	±10 %	± 300 mΩ	0.8 A	5.0 A	1.5 % + 20 mA
100 Ω	±10 %	± 500 mΩ	0.5 A	3.0 A	1.5 % + 10 mA
180 Ω	±10 %	± 1 Ω	0.25 A	1.35 A	1.5 % + 5 mA
500 Ω	±10 %	± 2.5 Ω	0.1 A	0.6 A	1.5 % + 3 mA
1 kΩ	±10 %	± 5 Ω	0.05 A	0.3 A	1.5 % + 2 mA
1.8 kΩ	±10 %	± 10 Ω	0.025 A	0.15 A	1.5 % + 2 mA

#### Notes:

- [1] Test currents up to 30 % of maximum continuous test current can be applied to the Calibrator with no time limitation. Test current between 30 % and 100 % of the maximum continuous test current can be applied to the Calibrator for a limited time. Minimum period of full current load is 45 seconds. The Calibrator calculates the allowed time period and when exceeded, the output connectors are disconnected.
- [2] Maximum short term test current is defined as the rms value of halfwave or fullwave test current flowing through the UUT. Maximum time of test is 200 ms. A time interval of 200 ms represents 10 full waves of power line voltage at 50 Hz and 12 full waves at 60 Hz.

## Test Current Measurement

**Range** ..... 0 to 40 A ac+ dc rms  
**Resolution** ..... 1 mA to 100 mA depending on resistance output and test current

## Open Mode

**Nominal resistance** ..... >100 kΩ  
**Maximum voltage** ..... 50 V ac+dc rms  
**Test voltage range** ..... 0 to 50 V ac+dc rms  
**Resolution** ..... 1 V  
**Uncertainty** ..... 2 % + 2 V

## Line/Loop Impedance Source

**Range**.....25 mΩ to 1.8 kΩ  
**Resolution**.....16 discrete values  
**Minimum test voltage/current**.....10 V/10 mA

### Uncertainty and Maximum Ratings

Nominal Resistance Value	Deviation from Nominal Value	Absolute Uncertainty of Characterized Value (tcal ±5 °C)	Maximum Continuous Test Current AC rms or DC <sup>[1]</sup>	Maximum Short-term Test Current AC rms or DC <sup>[2]</sup>	Test Current Uncertainty
25 mΩ	±50 %	±5 mΩ	30 A	40 A	1.5 % + 0.7 A
50 mΩ	±50 %	±5 mΩ	28 A	40 A	1.5 % + 0.5 A
100 mΩ	±30 %	±5 mΩ	25 A	40 A	1.5 % + 0.35 A
330 mΩ	±20 %	±7 mΩ	14 A	40 A	1.5 % + 0.3 A
500 mΩ	±10%	±8 mΩ	10 A	40 A	1.5 % + 0.2 A
1 Ω	±10 %	±10 mΩ	8 A	40 A	1.5 % + 150 mA
1.8 Ω	±10 %	±18 mΩ	6 A	30 A	1.5 % + 100 mA
5 Ω	±10 %	±30 mΩ	3.2 A	21 A	1.5 % + 70 mA
10 Ω	±10 %	±60 mΩ	2.0 A	15 A	1.5 % + 50 mA
18 Ω	±10 %	±100 mΩ	1.5 A	10 A	1.5 % + 30 mA
50 Ω	±10 %	±300 mΩ	0.8 A	5.0 A	1.5 % + 20 mA
100 Ω	±10 %	±500 mΩ	0.5 A	3.0 A	1.5 % + 10 mA
180 Ω	±10 %	±1 Ω	0.25 A	1.35 A	1.5 % + 5 mA
500 Ω	±10 %	±2.5 Ω	0.1 A	0.6 A	1.5 % + 3 mA
1 kΩ	±10 %	± 5 Ω	0.05 A	0.3 A	1.5 % + 2 mA
1.8 kΩ	±10 %	± 10 Ω	0.025 A	0.15 A	1.5 % + 2 mA

#### Notes:

- [1] Test currents up to 30 % of maximum continuous test current can be applied to the Calibrator with no time limitation. Test current between 30 % and 100 % of the maximum continuous test current can be applied to the Calibrator for a limited time. Minimum period of full current load is 45 seconds. The Calibrator calculates the allowed time period and when exceeded, the output connectors are disconnected.
- [2] Maximum short term test current is defined as the rms value of halfwave or fullwave test current flowing through the UUT. Maximum time of test is 200 ms. A time interval of 200 ms represents 10 full waves of power line voltage at 50 Hz and 12 full waves at 60 Hz.

## Test Current Measurement

**Type of recognized test current**.....Positive impulse (halfwave), negative impulse (halfwave), symmetrical (fullwave).  
**Range**.....0 to 40 A ac+dc rms  
**Resolution**.....1 to 100 mA depending on test current and resistance output

## Prospective Fault Current

**Range**.....0 to 10 kA

## Correction Manual Mode

**Residual Impedance Range**.....0 to 10 Ω  
**Resolution**.....1 mΩ  
**Uncertainty**.....Uncertainty in manual (MAN) mode is the uncertainty of selected resistance value. See table above. Also, the uncertainty of the manually entered correction should be taken into consideration.

## Correction Scan Mode

**Residual Impedance Range**.....0 to 10 Ω  
**Resolution**.....1 mΩ  
**Uncertainty**.....(1 % +15 mΩ) + uncertainty of selected resistance value.

## Correction COMP Mode (Active Loop Compensation) (5320A/VLC only)

**Residual Impedance Range**.....0 to 2 Ω  
**Maximum Test Current**.....<25/N A pk, where N equals number of UUT generated test current periods.  
**Uncertainty of compensation**.....(1 % + 15 mΩ) + uncertainty of selected resistance value. Uncertainty is valid at the point in time when the COMP function is initiated.

## Leakage Current Source

**Range**.....0.1 to 30 mA

### Resolution:

Passive Mode .....	10 µA setting, 1 µA measurement
Differential Mode.....	10 µA setting, 1 µA measurement
Substitute Mode.....	10 µA
Active Mode (5320A/VLC only).....	10 µA

### Test Voltage:

Passive Mode .....	60 to 250 V ac+dc rms
Differential Mode.....	60 to 250 V ac+dc rms
Substitute Mode.....	10 to 250 V ac+dc rms
Active Mode (5320A/VLC only).....	50 to 100 V ac+dc rms

### Uncertainty:

Passive Mode .....	0.3 % + 2 µA ac+dc rms
Differential Mode.....	0.3 % + 2 µA ac+dc rms
Test uncertainty can be influenced by power line voltage instability	
Substitute Mode.....	0.3 % + 2 µA ac+dc rms
Active Mode (5320A/VLC only).....	0.3 % + 1 µA ac+dc rms

## RCD (Residual Current Device)

### Trip Current Range:

0.5 X I and 1 X I mode: .....	3 to 3000 mA in 1 mA steps
1.4 X I and 2 X I Mode.....	3 to 1500 mA in 1 mA steps
5 X I Mode .....	3 to 600 mA in 1 mA steps

Trip Current Measurement Resolution.....	1 µA on 30 mA range 10 µA on 300 mA range 100 µA on 3A range
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### Uncertainty:

0.5 X I and 1 X I mode: .....	1 % rms
1.4 X I and 2 X I Mode.....	2 % rms
5 X I Mode .....	5 % rms

**Trip Time Range**.....10 to 5000 ms

**Trip Time Uncertainty**.....0.02 % + 0.25 ms

**Series Resistance**.....0.025 Ω, 0.05 Ω, 0.1 Ω, 0.33 Ω, 0.5 Ω, 1 Ω, 1.8 Ω, 5 Ω, 10 Ω, 18 Ω,  
50 Ω, 100 Ω, 180 Ω, 500 Ω, 1000 Ω, 1800 Ω

**Line/Touch Voltage Range**.....250 V

**Line/Touch Voltage Uncertainty**.....5 % + 3 V

## AC/DC Voltage Calibrator (5320A/VLC only)

**Range**.....3 to 600 V, ac or dc

**Resolution**.....4 digits

### Internal Ranges:

AC Mode .....	30, 100, 300, and 600 V (Autoranging only)
DC Mode .....	30, 150, and 600 V (Autoranging only)

### Frequency:

Range.....40 to 400 Hz

Resolution.....3 digits

Uncertainty.....0.02 %

**Settling Time**.....300 ms to 3 s, depending on output value

## AC Voltage

### Uncertainty and Maximum Burden Current

Range	Resolution	Uncertainty ±(% of Reading + mV)	Maximum Burden Current
3 – 29.99 V	0.001 V	0.1 % + 9	500 mA
30 – 99.99 V	0.01 V	0.1 % + 30	300 mA
100 – 299.9 V	0.1 V	0.1 % + 90	150 mA
300 – 600 V	0.1 V	0.1 % + 180	50 mA

## DC Voltage

### Uncertainty and Maximum Burden Current

Range	Resolution	Uncertainty ±(% of Reading + mV)	Maximum Burden Current
3 – 29.99 V	0.001 V	0.1 % + 9	2 mA
30 – 149.9 V	0.01 V	0.1 % + 45	3 mA
150 – 600 V	0.1 V	0.1 % + 180	5 mA

<b>AC Output Signal Distortion</b>	0.2 % $\pm$ 10 mV (harmonic distortion and non-harmonic noise from 20 Hz to 500 kHz), for output power lower than 10 VA on each range.
<b>Sensing Ammeter Current Range</b>	500 mA
<b>Resolution</b>	1 mA
<b>Uncertainty</b>	$\pm$ 5 mA

## Multimeter

### Voltage

<b>Range</b>	0 to 1100 V ac rms or dc
<b>Resolution</b>	4½ digits
<b>Internal Ranges</b>	10, 100, and 1100 V (Autoranging only)
<b>Frequency Range</b>	DC, 20 Hz to 2 kHz
<b>Input Resistance</b>	10 M $\Omega$ $\pm$ 1 %
<b>Time Constant</b>	1.5 s
<b>Readings/Second</b>	2
<b>Measurement Category</b>	1000 V CAT I, 300 V CAT II

### AC/DC Voltage Uncertainty

Range	Resolution	Uncertainty $\pm$ (% of Reading + mV)
10 V	0.001 V	0.15 % + 5
100 V	0.01 V	0.20 % + 50
1100 V	0.1 V	0.20 % + 550

### Current

<b>Range</b>	0 to 20 A continuous, 30 A for up to 30 minutes, ac rms or dc
<b>Resolution</b>	4½ digits
<b>Internal Ranges</b>	300 mA, 3 and 30 A (Autoranging only)
<b>Frequency Range</b>	DC, 20 to 400 Hz
<b>Time Constant</b>	1.5 s
<b>Readings/Second</b>	2

### AC/DC Current Uncertainty

Range	Resolution	Uncertainty $\pm$ (% of Reading + mA)
300 mA	0.1 mA	0.15 % + 0.15
3 A	1 mA	0.15 % + 1.5
30 A	10 mA	0.30 % + 15

### Phantom Power

<b>Range</b>	0 to 33 kVA
<b>Resolution</b>	3 digits
<b>Uncertainty</b>	$\sqrt{(V_{unc})^2 + (I_{unc})^2}$ where $V_{unc}$ is specified uncertainty of measured voltage and $I_{unc}$ is specified uncertainty of measured current.

### Hipot Leakage Current Measurement Mode

<b>Range</b>	0 to 300 mA ac rms or dc
<b>Resolution</b>	4 1/2 digits
<b>Frequency range</b>	DC, 20 Hz to 400 Hz
<b>Time constant</b>	1.5 s
<b>Readings/second</b>	2

### Hipot Leakage Current Mode Uncertainty

Range	Resolution	Uncertainty +/- (% of reading + $\mu$ A)
300 uA	0.01 $\mu$ A	0.3 % + 0.21
3 mA	0.1 $\mu$ A	0.2 % + 1.5
30 mA	1 $\mu$ A	0.2 % + 15
300 mA	10 $\mu$ A	0.2 % + 150

**Hipot Timer Measurement Mode**

**Range**.....0.1 to 999 s  
**Resolution**.....1 ms  
**Uncertainty**.....0.02 % + 2 ms (dc)  
                   0.02 % + 20 ms (ac)

**10 kV Adapter (1000:1 voltage divider)**

**Range**.....0 to 10 kV ac peak/dc  
**Resolution**.....4½ digits  
**Uncertainty**.....0.3 % of value + 5 V dc  
                   0.5 % of value + 5 V ac at 50 or 60 Hz

**80K-40 High Voltage Probe**

**Range**.....0 to 40 kV ac peak/dc  
**Resolution**.....4½ digits  
**Uncertainty**.....0.5 % of value + 10 V dc  
                   0.5 % of value + 10 V ac at 50 or 60 Hz

**Ordering information**

<b>Models</b>	<b>Description</b>
<b>5320A</b>	Multifunction Electrical Tester Calibrator
<b>5320A/40</b>	Calibrator with 40 kV Probe
<b>5320A/VLC</b>	Calibrator with 600 V Source and Active Loop Compensator
<b>5320A/VLC/40</b>	5320A/VLC Calibrator with 40 kV Probe

Note: All models include the 10 kV divider/resistance multiplier adapter as standard

**Accessories**

<b>5320A-LOAD</b>	Current Calibration Load Resistors
<b>5320CASE</b>	Rugged Transit Case
<b>Y5320</b>	Rack Mount Kit (Slides)

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